

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/673,336	TANAKA ET AL.
	Examiner	Art Unit
	Chuc D. Tran	2821

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
343	700 MS	7/17/2006	TC
343	909	7/17/2006	TC
Interference Search History		7/17/2006	TC